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Accurate fitting of measured reflectances using a Shifted Gamma micro-facet distribution

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Abstract

Material models are essential to the production of photo-realistic images. Measured BRDFs provide accurate representation with complex visual appearance, but have larger storage cost. Analytical BRDFs such as Cook-Torrance provide a compact representation but fail to represent the effects we observe with measured appearance. Accurately fitting an analytical BRDF to measured data remains a challenging problem. In this paper we introduce the SGD micro-facet distribution for Cook-Torrance BRDF. This distribution accurately models the behavior of most materials. As a consequence, we accurately represent all measured BRDFs using a single lobe. Our fitting procedure is stable and robust, and does not require manual tweaking of the parameters.

Categories and Subject Descriptors (according to ACM CCS): http://www.acm.org/class/1998/ I.3.7 [Computer Graphics]: Three-Dimensional Graphics and Realism—Color, shading, shadowing, and texture

1. Introduction

Photorealism in image synthesis depends strongly on the material representations we use. Measured BRDFs [MPBM03] provide a high degree of realism, but have storage issue (33 MB for a single isotropic material), making them harder to fit in a rendering pipeline. It is also difficult to use them with importance sampling, as they have no analytical definition.

BRDF models such as Phong, Lafortune or Cook-Torrance are much more compact: 8-10 parameters are enough to model an isotropic material, and are easy to combine with importance sampling in Monte-Carlo integration. We would like to compute the parameters of a BRDF model so that it photo-realistically resembles a measured material. Ngan et al. [NDM05] proved that diffuse and glossy materials are well approximated using single lobe Cook-Torrance or Lafortune BRDFs; the models are less accurate for specular materials such as metals, metallic paints or shiny plastics.

Adding more lobes to the BRDF model makes it more accurate, at the expense of the stability of the fitting process. 3 lobes are usually considered to be the limit for automatic fitting. Highly accurate fitting for all BRDFs, ranging from diffuse to highly specular, is still impractical.

This paper presents accurate and robust fitting for any BRDF (including metals) with a single lobe (in addition to the diffuse component). We use the Cook-Torrance BRDF model but with a different micro-facet distribution. The Cook-Torrance BRDF [TS67] simulates the micro geometry of a material as specular micro-facets and derives the BRDF mathematically from the probability distribution of
micro-facets. Although it is typically used with the Beckman distribution, the model can be used with many other distributions. Our study of measured BRDFs [MPBM03] shows that shiny materials do not follow the Beckmann distribution: micro-facets are more likely to be aligned with the surface normal, resulting in a sharper peak, consistent with the smooth appearance.

We introduce the SGD probability distribution function for micro-facets. This distribution provides a more accurate fitting for all measured materials, comparing to existing BRDF models, from highly shiny to diffuse. We use the Cook-Torrance BRDF with SGD distribution to approximate measured materials resulting in a compact and accurate representation. Since the SGD distribution approximates measured data very well, we were able to design a simpler fitting method. This method converges quickly (2.5 minutes on average) and it only uses two slices of the measured data to fit the unknown parameters.

This paper is organized as follows: in the next section, we review previous work on BRDF models and measurements. Then we present the Cook-Torrance model and micro-facet distributions. In section 4, we describe the SGD probability distribution function, and in section 5 our fitting method. Section 6 presents our results and compares them with previous work. In section 7, we conclude and discuss potential avenues for future work.

2. Previous work

Analytical BRDF models provide a reasonably realistic reflectance behavior at a very low computational and memory cost [TS67, CT82, War92, LFTG97]. Among these, micro-facet BRDF models assume that the surface geometry is made of specular micro-facets and the BRDF model depends on the facets’ slope distribution.

In the Cook-Torrance BRDF model [TS67, CT82], the reflectance is decomposed into a distribution term, a shadowing term, accounting for self-masking of the microgeometry, and a Fresnel term. For isotropic materials, the shadowing term is derived from the micro-facet distribution, through a double indefinite integration [Smi67, Bro80, BBS02]. Oren and Nayar [ON94] accounted for inter-reflections in the micro-geometry in addition to masking and shadowing. Ashikhmin et al. [APS00] proposed a formulation of micro-facet models that includes reciprocity and energy conservation. Weidlich and Wilkie proposed an extension of micro-facet models to multi-layer materials [WW07]. The Trowbridge-Reitz distribution [TR75] has stronger peak and larger tail than the Beckmann distribution. It is identical to the GGX distribution [WMLT07]. Low et al. [LYKU12] introduced a new reflectance model for glossy surfaces, with a different distribution, based on the Rayleigh-Rice theory, but do not include masking effects.

The Fresnel term depends on the wavelength, although this is often ignored. Schlick [Sch04] approximates the components of BRDF models with rational fractions for faster computations. His approximation of the Fresnel term is widely used today. Lazanyi et al. [LSK05] introduced a more accurate approximation of the Fresnel term.

Matusik et al. [MPBM03] measured reflectance properties for a large range of materials. We use their data-base for all our tests. Ngan et al. [NDM05] examined how classical BRDF models such as Lafontaine [LFTG97] and Ashikhmin-Shirley [APS00] can be used to approximate measured reflectances. They showed that Cook-Torrance [CT82] provide the best fits, and specular materials are poorly approximated with a single lobe; the quality of the fitting improves with multiple lobes, but the fitting process becomes unstable. A better fitting is recommended by global optimization with branching and bounding for multi-lobe cases [YSL11].

Ashikhmin and Premoze [AP07] computed the BRDF model directly from the data using back-scattering: if the input and output directions are equal, the entire BRDF model collapses into a 1D function, representing the micro-facet distribution. This function is read from the data and stored in a compact form. Wang et al. [WRG*09] used spherical Gaussians to approximate existing reflectance models, including Cook-Torrance and Lafontaine. The convolution of two spherical Gaussians is another spherical Gaussian, so BRDF expressed this way are easier to convolve with environment maps or normal distributions in the same model.

Romeiro et al. [RVZ08] and Pacanowski et al. [PSCS’12] project measured BRDFs on a two-dimensional space (θd, θh). Pacanowski approximates this projection with rational fractions, compressing the BRDF data down to 200 KB.

3. The Cook-Torrance reflectance model

The Cook-Torrance BRDF model [CT82] assumes that surfaces are made of random specular micro-facets (see Figure 2). The surface normal m follows a probability distribution function D. The full BRDF is:

\[
\rho(i, o) = \frac{\rho_d}{\pi} + \frac{\rho_s}{\pi} \frac{F(i \cdot h)D(\theta_h)G(i, o)}{\cos(\theta_i)\cos(\theta_o)}
\]
where \( i \) is the incoming direction, \( o \) is the outgoing direction, \( h \) is the half-vector (\( h = i + o \), normalized), \( \theta_i, \theta_o \) and \( \theta_0 \) are the respective angles between these vectors and the surface normal \( n \). \( p_d \) and \( p_s \) are the diffuse and specular coefficients, respectively (see notations on Figure 2).

\( D \) is the probability distribution function for micro-facet normals. \( G \) is the shading and masking coefficient, expressing the amount of light that is blocked by other micro-facets before reaching the point (shadowing), or after reflection (masking). For isotropic materials, \( G \) is approximated by a product of one-dimensional functions:

\[
G(i, o) \approx G_1(i)G_1(o)
\]

and \( G_1 \) is computed from \( D \) through a double integration [Smi67, Bro80, BBSO2, WMLT07].

\( F \) is the Fresnel term, depending on the refraction index \( \eta \) of the material. It is usually close to constant at normal incidence, and increases to unity at grazing angles.

### 3.1. The normal probability density, \( D \)

Given a direction \( \omega = (\theta, \phi) \) and an infinitesimal solid angle \( d\omega \), centered around this direction, the probability for the normal of a micro-facet to be inside the cone \( (\omega, d\omega) \) is \( D(\omega) \). 

In order to be physically plausible, \( D \) should follow several requirements: it should be positive, the projected area of the micro-facets in a direction should be equal to the projected area of the macro-surface and in particular, \( \int D(\omega) \omega \cdot d\omega = 1 \). \( D \) is usually expressed as:

\[
D(\theta) = \frac{\chi(0, \frac{\pi}{2})(\theta)}{\cos^2 \theta} P_{22}(\tan^2 \theta)
\]

where \( P_{22}(x) \) is a positive function of the variable \( x \in [0, \infty) \) and \( \chi(0, \frac{\pi}{2})(\theta) \) ensures sidedness: it is equal to 1 if \( \theta < \frac{\pi}{2} \), and 0 otherwise. With this expression,

\[
D(\theta)\cos \theta d\omega = \frac{1}{2} P_{22}(\tan^2 \theta) d(\tan^2 \theta)
\]

Since \( \int D(\theta) \omega \cdot d\omega = 1 \), we have \( \int_0^\infty P_{22}(x) dx = 1/\pi \).

We use this expression for importance sampling [WMLT07]: for a given incoming direction \( i \), we first pick a random micro-facet normal \( m \) with probability \( D(\theta_m) \cos \theta_m \), then compute the reflected direction \( o \) so that \( m \) is the half-vector. Finally, we compute the sampling weight as the BRDF divided by the probability, multiplied by the Jacobian of \( o \):

\[
w_o = \frac{\rho(i, o) \cos \theta_o}{D(\theta_m) \cos \theta_m} \left| \frac{\partial \theta_m}{\partial \omega} \right|
\]

To pick \( m \) with the probability \( D(\theta_m) \cos \theta_m \), we need the associated Cumulative Distribution Function \( F \):

\[
F(\theta_m, \phi_m) = \int_0^{\phi_m} \int_0^{\theta_m} D(\theta) \cos \theta d\omega = \frac{\phi_m}{2} \int_0^{\tan^2 \theta_m} P_{22}(u) du
\]

### Table 1: \( P_{22} \) functions corresponding to classical micro-facet distributions, with \( x = \tan^2 \theta \).

<table>
<thead>
<tr>
<th>Distribution</th>
<th>Formula</th>
</tr>
</thead>
<tbody>
<tr>
<td>Beckmann</td>
<td>( \frac{1}{\pi \sigma^2} e^{-x/\sigma^2} )</td>
</tr>
<tr>
<td>Exponential</td>
<td>( \frac{1}{2\sqrt{\pi}} e^{-x^2/\sigma^2} )</td>
</tr>
<tr>
<td>TR/GGX</td>
<td>( x^2 e^{-x^2/\sigma^2} )</td>
</tr>
</tbody>
</table>

\( P_{22}(x) \) is separable: \( F = F_\phi F_\theta \), with \( F_\phi \) and \( F_\theta \) from 0 to 1:

\[
F_\phi(\phi_m) = \frac{\phi_m}{2\pi}
\]

\[
F_\theta(\theta_m) = \pi \int_0^{\tan^2 \theta_m} P_{22}(u) du
\]

Assuming we have two uniform random variables \( u_1 \) and \( u_2 \) in \([0, 1]\), we get the sampling equations:

\[
\phi_m = F_\phi^{-1}(u_1) = 2\pi u_1
\]

\[
\theta_m = F_\theta^{-1}(u_2)
\]

For any micro-facet distribution \( D \) following Equation 2, importance sampling reduces to computing the integral of \( P_{22} \) and inverting it.

### 3.2. Shadowing and masking

In early versions of the Cook-Torrance BRDF [TS67] the shadowing function \( G \) was independent from the micro-facet distribution. Further research [Smi67, Bro80, BBSO2] proved that we get a more accurate shadowing term by integration from the micro-facet distribution \( D \). \( G \) is approximated as the product of two one-dimensional functions: \( G(i, o) \approx G_1(\theta)G_1(\theta) \). \( G_1 \) is computed from \( D \) through a double integration:

\[
P_2(r) = \int_{-\infty}^{\infty} P_{22}(r^2 + q^2) dq
\]

\[
\Lambda(\theta) = \int_{-\infty}^{\infty} (r \tan \theta - 1) P_2(r) dr
\]

\[
G_1(\theta) = \chi(0, \frac{\pi}{2})(\theta) / (1 + \Lambda(\theta))
\]

For further details, please refer to the original papers or the short summary in [WMLT07].

### 3.3. Existing distributions

Table 1 lists the \( P_{22} \) functions corresponding to existing micro-facet distributions. Beckmann is frequently used [CT82]; it is a Gaussian in \( \tan \theta \), and is also very close to the Phong distribution [WMLT07]. The exponential distribution is mostly used for the propagation of radio waves [BBSO2, Bro80], and has a sharper peak and larger tails than Beckmann. The Trowbridge-Reitz/GGX distribution [TR75, WMLT07] has a sharper peak and larger tails than Beckmann and Exponential distributions.
4. Our reflectance model

4.1. Data observation

It is hard to compare measured data with BRDF models, since models depend on position and several functions. For simple comparisons, we take \( i = o \). As a consequence, \( h = i \); we get an equation that only depends on \( \theta_h \), with two unknown functions \( D \) and \( G_1 \) [AP07]:

\[
\rho(\theta_h) = \frac{\alpha d}{\pi} + \frac{\rho_s}{\pi} \frac{F(0)D(\theta_h)G_1(\theta_h)^2}{\cos^2(\theta_h)}
\]

(7)

For small values of \( \theta_h \) and specular materials, \( G_1 \) is almost constant, equal to 1 (see Figure 5). The measured data varies only with \( D \), and we can observe directly the micro-facet distribution.

Figure 3 compares the measured distribution \( D \) for brass from the MERL database [MPBM03] with approximations using different distributions. The peak of the measured distribution is much sharper than the predictions, while the tail is larger. If we fit the tail accurately (for example with the Beckmann distribution, \( \alpha = 7 \times 10^{-5} \)), then we miss the peak. On the other hand, if we fit the peak well, we miss the tail. To fit this data with existing distributions we would need several lobes. This observation holds for many materials in the MERL database: metals, metallic paints and shiny plastics.

At large angles, the measured distribution seem to decrease exponentially. But for small angles, the decrease is sharper than an exponential. Based on this observation, we suggest a slope in \( x^{-\alpha} \), where \( x = \tan^2 \theta_h \) and \( p \) is a parameter that depends on the model, multiplied by an exponential factor:

\[
P_{22}(x, \alpha, p) = \frac{K_{\alpha, p}e^{-\frac{x}{(x + \alpha^2)}}}{(x + \alpha^2)^p}
\]

(8)

where \( K_{\alpha, p} \) is a normalization factor. With this distribution, we fit the measured data accurately (see Figure 3(b)), both at the peak and the tail.

4.2. The SGD distribution

We compute the normalization factor \( K_{\alpha, p} \) so that \( \int_0^\infty P_{22}(x)dx = 1/\pi \). The result is a shifted gamma distribution (SGD):

\[
P_{22}(x) = \frac{\alpha^{p-1}}{\Gamma(1-p, \alpha)} e^{-\frac{x}{\alpha}} \frac{x^{p-1}}{(\alpha + x)^p}
\]

\[
D(\theta_m) = \frac{\chi(0, \frac{1}{\alpha})}{\pi \cos \theta_m} P_{22}(\tan^2 \theta_m)
\]

\( \Gamma \) is the incomplete Gamma function: \( \Gamma(x, y) = \int_y^\infty t^{x-1}e^{-t}dt \)

The SGD fits accurately a large range of materials, from diffuse to specular (see Figures 3(b), 4 and the supplemental material).

4.3. Shadowing and masking

Once we have \( D \), we can compute the shadowing and masking function, \( G_1 \), using Equation 6:

\[
P_2(r) = \frac{1}{\sqrt{\pi}(1-p, \alpha)} U\left(p, p + \frac{1}{2}, \alpha^2 + x^2\right) e^{-\frac{x^2}{\alpha^2}}
\]

\[
A(\theta) = \int_{\theta_0}^{\infty} (\tan^2 \theta - 1) P_2(\theta)d\theta
\]

\[
G_1(\theta) = \frac{\chi(0, \frac{1}{\alpha})(\theta)}{1 + A(\theta)}
\]

where \( U \) is the confluent hyper-geometric function of the second kind. We do not have a closed form expression for \( G_1 \). We either pre-compute \( G_1 \) using Gauss integration and store its values for varying \( \theta \) or use the following approximation:

\[
G_1(\theta) \approx \begin{cases} 
1 + \lambda \left(1 - e^{-\theta} \right) & \text{if } \theta > \theta_0 \\
1 & \text{if } \theta \leq \theta_0 
\end{cases}
\]

(9)

\[
\theta_0 = \frac{\pi}{2} \left( \frac{\log \left( 1 + \frac{1}{\lambda} \right) }{c} \right)^{\frac{1}{2}}
\]
θ₀ ensures that G₁(π/2) = 0. We get the (λ, c, k) parameters by fitting the approximation over the precomputed values, using Levenberg-Marquadt [Lout04]. This approximation is a very good fit for G₁ for all materials (the L₂ error is negligible, mostly below 10⁻⁵, see Figure 5).

The choice between using stored values for G₁ and the approximation depends on the processing power, memory bandwidth and storage capacities. For offline rendering, where storage is not an issue, we use precomputed values. For GPU rendering, we use the approximation.

4.4. The Fresnel term

Since we have an expression for D and G₁, we can express the Fresnel term using the measured data:

\[ F(\mathbf{i} \cdot \mathbf{h}) = \left( m(\mathbf{i}, \mathbf{o}) - \frac{\theta_d}{\pi} \right) \frac{\pi \cos \theta_i \cos \theta_o}{\rho_d D(\theta_i) G_1(\theta_i) G_1(\theta_o)} \]  \quad (10)

where \( m(\mathbf{i}, \mathbf{o}) \) is the measured data. For simplicity, we will note \( \theta_d = \arccos(\mathbf{i} \cdot \mathbf{h}) \). Looking at the data for the Fresnel term, we make two important observations:

- The measured data behaves strangely at grazing angles. In theory, the Fresnel term should be increasing with \( \theta_d \) up to 1 when \( \theta_d = \pi/2 \). The Fresnel term extracted from the measured data starts decreasing after a certain angle (from 70° to 80°), and is equal to 0 for \( \theta_d = \pi/2 \) (see Figure 6(a)). This is probably caused by the acquisition process: at grazing angles, the sensor is saturated by direct illumination from the light source. We discard data for \( \theta_d > 70° \).
- For some materials such as gold-paint or nickel, the Fresnel term does not behave as predicted by the Schlick approximation (see Figure 6(b)). Instead of a plateau followed by a sharp increase, we observe linear slope, followed by an increase. To model these materials, we suggest the following generalization of Schlick approximation:

\[ F(\theta_d) = F_0 + (1 - F_0)(1 - \cos \theta_d)^5 - F_1 \cos \theta_d \]  \quad (11)

For \( F_1 = 0 \), we get the original approximation.

4.5. Importance sampling

Efficient Monte-Carlo integration requires importance sampling. For this, we need the inverse of the integral of \( P_{22} \) (see Equation 5). We easily have \( F_0 \):

\[ F_0 = 1 - \frac{\Gamma \left( 1 - \rho + \tan^2 \theta \right)}{\Gamma (1 - \rho, \alpha)} \]

but there is no closed form expression for the inverse for \( F_0 \), so we can’t use it for exact importance sampling. As an approximation, we importance sample the GGX distribution [WMLT07], and compute weights, \( w \), to fit our model:

\[ \theta_{in} = \arctan \left( \frac{\alpha w}{\sqrt{1 - w^2}} \right) \]

\[ \uparrow F. \ Durand, \ personal \ communication. \]
and the supplemental material). Often, we get very similar values for different materials (see Figures 1, 8, and 10 and the supplemental). We attribute this to the very good match between our distribution function and the data behavior.

5. Fitting algorithm

5.1. Fitting RGB channels separately

Fitting BRDF models with measured materials is usually done in a two-step approach [NDM05]: first compute the diffuse and specular colors using a linear least square optimization, then compute the BRDF parameters \((\alpha, F_0)\) through a second optimization.

This approach places constraints on the second optimization process: the parameters must fit all RGB channels. We used a different approach: we compute the BRDF parameters separately for each channel, red, green and blue. Although we compute and store more data for each material, the fitting process is faster and more efficient, as we only fit real-valued functions, with less constraints for each fitting.

We also get wavelength dependent effects. The Fresnel term should change with the wavelength [LSK05] and we do find different values for \(F_0\) and \(F_1\) for the red, green and blue channels, for all materials in the MERL database (see supplemental material). Often, we get very similar values for the \(\alpha\) and \(p\) parameters for the micro-facet distribution.

We do not take any explicit step to conserve the color of the material, since we treat each channel independently. We still get BRDF models that match very well the color of the measured materials (see Figures 1, 8, and 10 and the supplemental). We attribute this to the very good match between our distribution function and the data behavior.

5.2. Non-linear optimization

Given the measured data for a single channel, we find the optimal value for the parameters \((p_d, p_s, \alpha, p, F_0, F_1)\) so that the BRDF model is as close as possible to the measured data.

We could compute the \(L_2\) norm of the difference between the BRDF model and the measured BRDF over the whole hemisphere, as in [NDM05]. But regular sampling in \(\theta_i\) and \(\theta_o\) results in under-sampling near the specular peak, resulting in poor quality fits. Instead we fit in two steps:

1. We fit the probability distribution parameters \((\alpha, p)\) to the measured data for varying \(\theta_i\), with \(\theta_d = 0\).
2. We fit the Fresnel term parameters \((F_0, F_1)\) to the measured data for varying \(\theta_d\), with \(\theta_i = 0\).

Figure 6: The Fresnel term extracted from the measured data does not behave as predicted by the theory.
Each step is the fitting of a real-valued function of several parameters, which is simple and stable. Although we fit the parameters using only two slices of the measured reflectance, we still capture the full behavior of the BRDF.

We define the following quantities:

- \( m(i, o) \): the full measured reflectance, as extracted from the database,
- \( m_h(\theta_h) = m(h, h) \): the slice of the BRDF corresponding to \( \theta_d = 0 \),
- \( m_d(\theta_d) = m(i, \text{reflection}(i)) \): the slice of the BRDF corresponding to \( \theta_s = 0 \).

In a first step, we fit \( m_h(\theta_h) \) with:

\[
\rho_d(\theta_h) = \frac{\rho_d}{\pi} \frac{F_r D(\theta_h)G^2(\theta_h)}{\cos^2(\theta_h)}
\]

The function \( \rho_d \) depends on 4 parameters: \( \rho_d, F_r, \alpha \) and \( p \). Using Levenberg-Marquadt optimization \cite{Levenberg:36}, \( \rho_d \) and the Fresnel term for \( \theta_d = 0 \).

In the second step, we first extract the specular coefficient times the Fresnel term from \( m_d(\theta_d) \) using the values \( \rho_d, \alpha \) and \( p \) we just computed:

\[
\rho_s F_p(\theta_d) = \left(m_d(\theta_d) - \frac{\rho_d}{\pi} \frac{\pi \cos^2(\theta_d)}{D(\theta_d)G^2(\theta_d)} \right)
\]

We fit this function with our Fresnel term approximation (Equation 11), using Levenberg-Marquadt optimization. The data gives us \( \rho_s, F_0 \) and \( \rho_s, F_1 \). Using \( F_1(\pi/2) = 1 \), we get \( \rho_s, F_0 \) and \( F_1 \).

6. Results and Comparison

6.1. Visual comparison

Figures 8 and 10 shows a side-by-side comparison for aventurine and colonial-maple-223 between images rendered using the measured reflectance from the MERL database and several BRDF models: Lafortune and Cook-Torrance with the Beckmann, TR/GGX and SGD distributions. For each model, we show the difference with the reference image, measured in Lab space. We chose the Lab color space because it is perceptually uniform. Qualitatively, our BRDF model provides the best approximation to the measured data.

In the supplemental material, we provide a similar comparison for all 100 materials in the MERL database: reference image and Cook-Torrance BRDF with Beckmann and SGD distributions, along with differences in Lab space.

![Figure 11: Normalized fitting errors (logarithmic scale) of the Cook-Torrance model with Beckmann and SGD distributions. In most cases, SGD provides a much better fit.](image)

For 13 materials in the database, we couldn’t find the corresponding parameters in the supplemental of [NDM05], so we only provide the comparison between the measured material and our distribution. Visually, the Cook-Torrance BRDF with the SGD distribution looks very close to the measured reflectance.

6.2. BRDF Lobes comparison

Figures 8(j), 10(j) and 9, plot the BRDF lobes for aventurine, colonial-maple-223, hematite, black-obsidian, nickel, and black-oxidized-steel, with the Beckmann, GGX and SGD distributions compared to the measurements, for four incoming directions (10°, 30°, 50°, and 70°).

The SGD distribution closely fits the measured data, while the Beckmann distribution either misses the tail by trying to fit the peak of the lobe, or vice-versa. This is particularly evident for black-obsidian where the Beckmann distribution underestimates the peak. In the hematite, aventurine, nickel, black-oxidized-steel, and colonial-maple-223 cases, which are ranging from highly-specular to glossy-specular and glossy-diffuse, the Beckmann distribution significantly overestimates the lobes. The GGX distribution performs better than Beckmann and SGD is very close to the actual shape of the lobes.

The supplemental material provides the same comparison for all 100 materials in the MERL database: lobes from the measured data and lobes from the Cook-Torrance BRDF, using Beckmann and SGD distributions. For most materials, the SGD distribution is very close to the measured data.

6.3. Quantitative Error Measure

For each material, we define the fitting error as the \( L_2 \) norm of the difference between measured data and the Cook-Torrance BRDF:

\[
E = \left( \int (m(i, o) - \rho(i, o))^2 \cos \theta_i \cos \theta_o d\omega \right)^{\frac{1}{2}}
\]
Figure 8: Comparison between the Cook-Torrance model with Beckmann, TR/GGX and SGD distributions, Lafortune and ground truth for aventurine from the MERL database (spelled aventurnine in [NDM05]).

Figure 9: BRDF lobes (cubic root applied) with Beckmann, GGX and SGD distributions for hematite, black-obsidian, nickel, and black-oxidized-steel. The SGD distribution provides a much closer fit to measured reflectance than the Beckmann and GGX distribution.

To ensure a fair comparison between bright and dark materials, we normalize this error by dividing it with the maximum albedo of the BRDF, as in [NDM05] (the supplemental has the un-normalized error value). Figure 11 compares the fitting errors for the Cook-Torrance BRDF using the SGD and Beckmann distributions (parameters for Beckmann from [NDM05]). We sorted the materials by increasing $\alpha$ roughness, going from highly specular to diffuse. For all but 3 of the materials (black-fabric, yellow-matte-plastic, and white-paint), the SGD distribution provides the best approximation. For many materials, we improve the accuracy by one order of magnitude, and for some, such as hematite, by two orders of magnitude.

For the materials where we do not improve over Beckmann distribution, we think that the problem comes from the fitting algorithm rather than the SGD distribution. Manually setting the parameters for these materials improves the accuracy (all the parameters we use in this paper were computed in a single run of our optimization process, without any tweaking for specific materials).

To evaluate our fitting method, we used it to compute parameters for the Beckmann and TR/GGX distributions, and reported the error for each material in Figure 11. For almost all materials, the error is higher than with Beckmann distribution and parameters from [NDM05]. Our fitting method works better if the shape of the distribution matches the measured data.

Figure 12 provides a pixel-by-pixel comparison for a horizontal scanline of rendered image between: measured reflectance, Cook-Torrance with Beckmann distribution and SGD distribution, with and without importance sampling. The Beckmann distribution overestimates specular lobes;
Accurate fitting of measured reflectances using a Shifted Gamma micro-facet distribution

Figure 10: Comparison between the Cook-Torrance model with Beckmann, TR/GGX and SGD distributions, Lafortune and ground truth for colonial-maple-223 from the MERL database.

Figure 12: Pixel by pixel comparison between the reference, Beckmann and SGD (with and without importance sampling) for aventurine from MERL database.

SGD remains very close to the reference. The figure also validates that using GGX importance sampling for SGD distribution gives the same results, but reduces the noise.

6.4. Timings

Since our algorithm only uses two slices of the BRDF measurement for fitting the parameters, it is extremely fast: 2.5 minutes on average to fit all the parameters for a single material on a single core 2.57 GHz Intel CPU. For 65% of the materials, the fitting process took less than 1 minute.

6.5. Limitations

For some materials in the MERL database, even with the SGD distribution, we see evidence of a multi-lobe behavior. This is quite obvious for two-layer-gold and two-layer-silver (see Figure 13), and it appears (but it’s less obvious) for alum-bronze. For these materials, adding a second lobe would improve the accuracy. However, the number of materials with multi-lobe behavior is 3 out of 100.

We also measured the cost of evaluating our reflectance model inside a ray-tracer, using valgrind profiling tool. A single evaluation takes 3044 CPU cycles, compared to 1416 with Beckmann and 551 with Lafortune. Our model is more expensive because we estimate the BRDF independently for each color channel.

Figure 13: An example of a two-layer material, two-layer-silver, that requires two lobes for accurate fitting.
Cook-Torrance model. It will miss behavior that are outside of the model, for example color-changing-paint.

The white-paint material illustrates a failure case of our fitting algorithm (see Figure 14). The error with SGG is larger than with Beckmann. The difference is clearly visible in the rendered pictures (Figure 14(b)). A possible explanation is visible in the lobes (Figure 14(c)): the Fresnel term is almost null at normal incidence, and our fitting algorithm does not pick the right shape for the specular lobe.

7. Conclusion and Future work

We have presented the SGD micro-facet probability distribution function for the Cook-Torrance BRDF. This distribution provides an accurate fit for most measured materials. We have also presented a new fitting algorithm, where we fit each color channel independently (instead of precomputing the diffuse and specular colors), and we fit using only two slices of the BRDF. This fitting algorithm is very efficient when combined with the SGD distribution, taking 2.5 mn to compute the parameters for a measured distribution.

In the supplemental, we provide parameters for the SGD distribution for all materials in the MERL database, as well as GLSL code. We hope that this will help researchers and software developers in using the SGD distribution.

In future work, we want to continue working on micro-facet distributions, finding a distribution that provides the same accurate fit to measured data while being easier to compute and integrating into nicer functions. We also want to target material acquisition: we describe an acquired material accurately with only 18 coefficients. Can we use this property for faster acquisition of new materials?

References


